

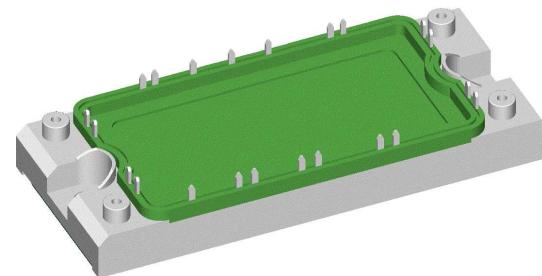
Thyristor Module

3~ Rectifier	Brake Chopper
$V_{RRM} = 1600$	$V_{CES} = 1200$
$I_{DAV} = 180$	$I_{C25} = 180$
$I_{FSM} = 1100$	$V_{CE(sat)} = 1.7$

3~ Rectifier Bridge, half-controlled (high-side) + Brake Unit + NTC

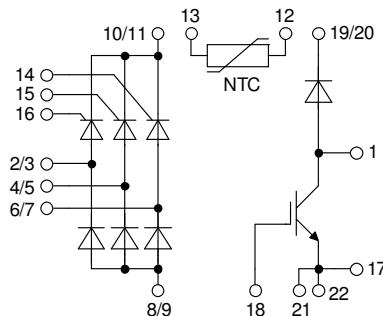
Part number

VVZB170-16ioXT



Backside: isolated

E72873



Features / Advantages:

- Package with DCB ceramic
- Improved temperature and power cycling
- Planar passivated chips
- Very low forward voltage drop
- Very low leakage current
- NTC
- X2PT - 2nd generation Xtreme light Punch Through
- Rugged X2PT design results in:
 - short circuit rated for 10 µsec.
 - very low gate charge
 - low EMI
 - square RBSOA @ 2x Ic
- Thin wafer technology combined with X2PT design results in a competitive low VCE(sat) and low thermal resistance

Applications:

- 3~ Rectifier with brake unit for drive inverters

Package: E2-Pack

- Isolation Voltage: 3600 V~
- Industry standard outline
- RoHS compliant
- Soldering pins for PCB mounting
- Height: 17 mm
- Base plate: DCB ceramic
- Reduced weight
- Advanced power cycling

Terms & Conditions of usage:

The data contained in this product data sheet is exclusively intended for technically trained staff. The user will have to evaluate the suitability of the product for the intended application and the completeness of the product data with respect to his application. The specifications of our components may not be considered as an assurance of component characteristics. The information in the valid application- and assembly notes must be considered. Should you require product information in excess of the data given in this product data sheet or which concerns the specific application of your product, please contact your local sales office.

Due to technical requirements our product may contain dangerous substances. For information on the types in question please contact your local sales office. Should you intend to use the product in aviation, in health or life endangering or life support applications, please notify. For any such application we urgently recommend

- to perform joint risk and quality assessments;
- the conclusion of quality agreements;
- to establish joint measures of an ongoing product survey, and that we may make delivery dependent on the realization of any such measures.

Rectifier			Ratings			
Symbol	Definition	Conditions	min.	typ.	max.	Unit
$V_{RSM/DSM}$	max. non-repetitive reverse/forward blocking voltage	$T_{VJ} = 25^\circ C$			1700	V
$V_{RRM/DRM}$	max. repetitive reverse/forward blocking voltage	$T_{VJ} = 25^\circ C$			1600	V
$I_{R/D}$	reverse current, drain current	$V_{R/D} = 1600 V$ $V_{R/D} = 1600 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 150^\circ C$		50 20	μA mA
V_T	forward voltage drop	$I_T = 60 A$ $I_T = 180 A$ $I_T = 60 A$ $I_T = 180 A$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$		1.27 1.90 1.25 2.04	V V
I_{DAV}	bridge output current	$T_C = 85^\circ C$ rectangular $d = \frac{1}{3}$	$T_{VJ} = 150^\circ C$		180	A
V_{T0} r_T	threshold voltage slope resistance } for power loss calculation only		$T_{VJ} = 150^\circ C$		0.83 6.9	V $m\Omega$
R_{thJC}	thermal resistance junction to case				0.5	K/W
R_{thCH}	thermal resistance case to heatsink				0.100	K/W
P_{tot}	total power dissipation		$T_C = 25^\circ C$		250	W
I_{TSM}	max. forward surge current	$t = 10 ms; (50 Hz)$, sine $t = 8,3 ms; (60 Hz)$, sine $t = 10 ms; (50 Hz)$, sine $t = 8,3 ms; (60 Hz)$, sine	$T_{VJ} = 45^\circ C$ $V_R = 0 V$ $T_{VJ} = 150^\circ C$ $V_R = 0 V$		1.10 1.19 935 1.01	kA kA
I^2t	value for fusing	$t = 10 ms; (50 Hz)$, sine $t = 8,3 ms; (60 Hz)$, sine $t = 10 ms; (50 Hz)$, sine $t = 8,3 ms; (60 Hz)$, sine	$T_{VJ} = 45^\circ C$ $V_R = 0 V$ $T_{VJ} = 150^\circ C$ $V_R = 0 V$		6.05 5.89 4.37 4.25	kA^2s kA^2s kA^2s kA^2s
C_J	junction capacitance	$V_R = 400 V$ $f = 1 MHz$	$T_{VJ} = 25^\circ C$		54	pF
P_{GM}	max. gate power dissipation	$t_p = 30 \mu s$ $t_p = 300 \mu s$	$T_C = 150^\circ C$		10 5 0.5	W W W
P_{GAV}	average gate power dissipation					
$(di/dt)_{cr}$	critical rate of rise of current	$T_{VJ} = 150^\circ C$; $f = 50 Hz$ repetitive, $I_T = 180 A$ $t_p = 200 \mu s$; $di_G/dt = 0.45 A/\mu s$; — $I_G = 0.45 A$; $V = \frac{2}{3} V_{DRM}$ non-repet., $I_T = 60 A$			150	$A/\mu s$
$(dv/dt)_{cr}$	critical rate of rise of voltage	$V = \frac{2}{3} V_{DRM}$ $R_{GK} = \infty$; method 1 (linear voltage rise)	$T_{VJ} = 150^\circ C$		1000	$V/\mu s$
V_{GT}	gate trigger voltage	$V_D = 6 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = -40^\circ C$		1.5 1.6	V
I_{GT}	gate trigger current	$V_D = 6 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = -40^\circ C$		95 200	mA mA
V_{GD}	gate non-trigger voltage	$V_D = \frac{2}{3} V_{DRM}$	$T_{VJ} = 150^\circ C$		0.2	V
I_{GD}	gate non-trigger current				10	mA
I_L	latching current	$t_p = 10 \mu s$ $I_G = 0.45 A$; $di_G/dt = 0.45 A/\mu s$	$T_{VJ} = 25^\circ C$		450	mA
I_H	holding current	$V_D = 6 V$ $R_{GK} = \infty$	$T_{VJ} = 25^\circ C$		200	mA
t_{gd}	gate controlled delay time	$V_D = \frac{1}{2} V_{DRM}$ $I_G = 0.45 A$; $di_G/dt = 0.45 A/\mu s$	$T_{VJ} = 25^\circ C$		2	μs
t_q	turn-off time	$V_R = 100 V$; $I_T = 60 A$; $V = \frac{2}{3} V_{DRM}$ $T_{VJ} = 125^\circ C$ $di/dt = 10 A/\mu s$ $dv/dt = 20 V/\mu s$ $t_p = 200 \mu s$		150		μs

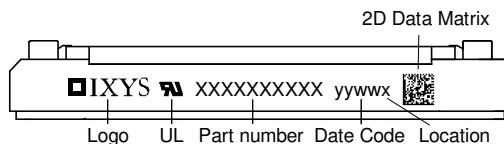
Brake IGBT

Symbol	Definition	Conditions	Ratings				
			min.	typ.	max.	Unit	
V_{CES}	collector emitter voltage	$T_{VJ} = 25^\circ C$			1200	V	
V_{GES}	max. DC gate voltage				± 20	V	
V_{GEM}	max. transient gate emitter voltage				± 30	V	
I_{C25}	collector current	$T_C = 25^\circ C$			180	A	
I_{C80}		$T_C = 80^\circ C$			140	A	
P_{tot}	total power dissipation	$T_C = 25^\circ C$			500	W	
$V_{CE(sat)}$	collector emitter saturation voltage	$I_C = 100 A; V_{GE} = 15 V$	$T_{VJ} = 25^\circ C$	1.7	2.1	V	
			$T_{VJ} = 125^\circ C$	1.9		V	
$V_{GE(th)}$	gate emitter threshold voltage	$I_C = 4 mA; V_{GE} = V_{CE}$	$T_{VJ} = 25^\circ C$	6	6.8	7.5	V
I_{CES}	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$		0.1	mA	
			$T_{VJ} = 125^\circ C$	0.1		mA	
I_{GES}	gate emitter leakage current	$V_{GE} = \pm 20 V$			500	nA	
$Q_{G(on)}$	total gate charge	$V_{CE} = 600 V; V_{GE} = 15 V; I_C = 100 A$		340		nC	
$t_{d(on)}$	turn-on delay time	inductive load $V_{CE} = 600 V; I_C = 100 A$ $V_{GE} = \pm 15 V; R_G = 6.8 \Omega$		230		ns	
t_r	current rise time			70		ns	
$t_{d(off)}$	turn-off delay time			380		ns	
t_f	current fall time			230		ns	
E_{on}	turn-on energy per pulse			12.5		mJ	
E_{off}	turn-off energy per pulse			11.5		mJ	
RBSOA	reverse bias safe operating area	$V_{GE} = \pm 15 V; R_G = 6.8 \Omega$	$T_{VJ} = 125^\circ C$				
I_{CM}		$V_{CEK} = 1200 V$			300	A	
SCSOA	short circuit safe operating area	$V_{CEK} = 1200 V$					
t_{sc}	short circuit duration	$V_{CE} = 720 V; V_{GE} = \pm 15 V$	$T_{VJ} = 125^\circ C$		10	μs	
I_{sc}	short circuit current	$R_G = 6.8 \Omega$; non-repetitive		450		A	
R_{thJC}	thermal resistance junction to case				0.25	K/W	
R_{thCH}	thermal resistance case to heatsink			0.10		K/W	

Brake Diode

V_{RRM}	max. repetitive reverse voltage	$T_{VJ} = 25^\circ C$		1200	V
I_{F25}	forward current	$T_C = 25^\circ C$		48	A
I_{F80}		$T_C = 80^\circ C$		32	A
V_F	forward voltage	$I_F = 30 A$	$T_{VJ} = 25^\circ C$	2.75	V
			$T_{VJ} = 125^\circ C$	1.60	V
I_R	reverse current	$V_R = V_{RRM}$	$T_{VJ} = 25^\circ C$	0.25	mA
			$T_{VJ} = 125^\circ C$	1	mA
Q_{rr}	reverse recovery charge	$V_R = 600 V$ $-di_F/dt = 1000 A/\mu s$ $I_F = 30 A$		5.2	μC
				50	A
				300	ns
				1.9	mJ
R_{thJC}	thermal resistance junction to case			0.9	K/W
R_{thCH}	thermal resistance case to heatsink			0.3	K/W

Package E2-Pack			Ratings			
Symbol	Definition	Conditions	min.	typ.	max.	Unit
I_{RMS}	RMS current	per terminal			200	A
T_{VJ}	virtual junction temperature		-40		150	°C
T_{op}	operation temperature		-40		125	°C
T_{stg}	storage temperature		-40		125	°C
Weight				176		g
M_D	mounting torque		3		6	Nm
$d_{Spp/App}$	creepage distance on surface / striking distance through air		terminal to terminal		6.0	mm
$d_{Spb/Apb}$			terminal to backside		12.0	mm
V_{ISOL}	isolation voltage	t = 1 second t = 1 minute	50/60 Hz, RMS; $I_{ISOL} \leq 1$ mA		3600 3000	V V

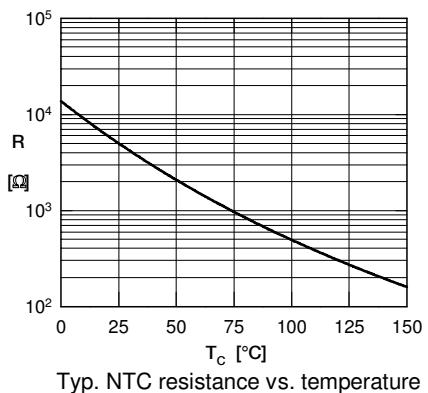


Ordering	Ordering Number	Marking on Product	Delivery Mode	Quantity	Code No.
Standard	VVZB170-16ioXT	VVZB170-16ioXT	Box	6	510482

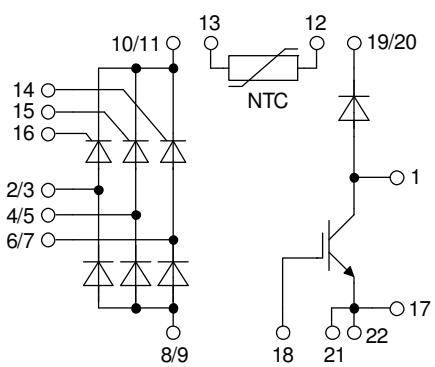
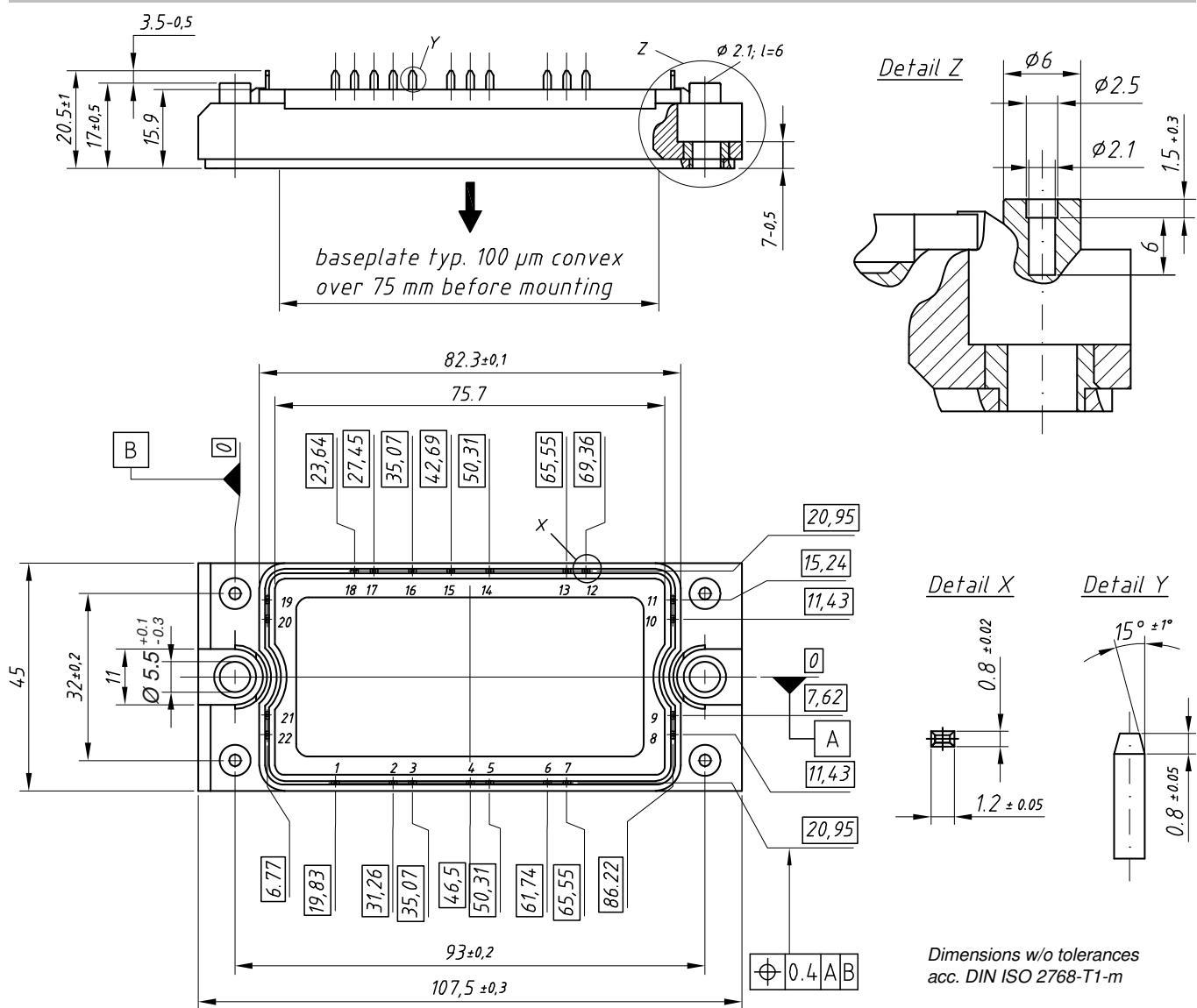
Temperature Sensor NTC

Symbol	Definition	Conditions	min.	typ.	max.	Unit
R_{25}	resistance	$T_{VJ} = 25^\circ C$	4.75	5	5.25	kΩ
$B_{25/50}$	temperature coefficient			3375		K

Equivalent Circuits for Simulation			* on die level	$T_{VJ} = 150^\circ C$
I → V_0 → R_0 →	Thyristor	Brake Diode		
$V_{0\max}$	threshold voltage	0.83	1.31	V
$R_{0\max}$	slope resistance *	3.7	8	mΩ



Outlines E2-Pack



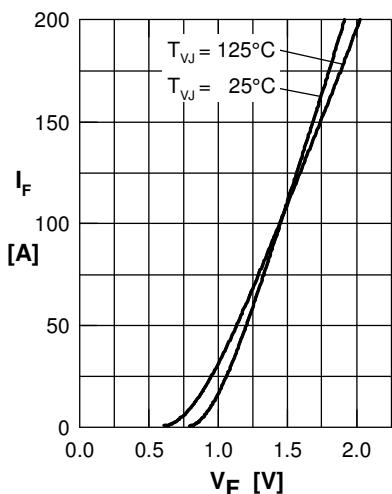
Thyristor

Fig. 1 Forward current vs. voltage drop per diode

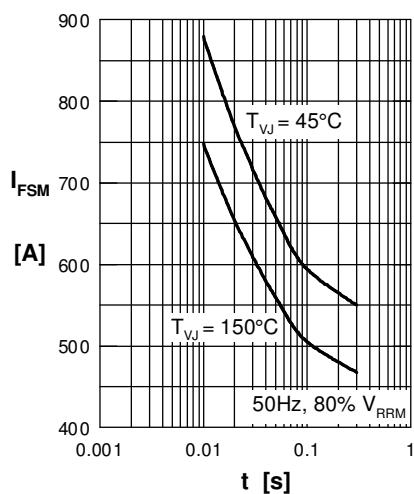


Fig. 2 Surge overload current vs. time per diode

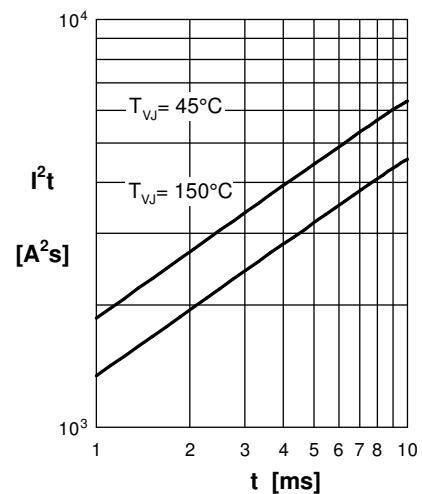
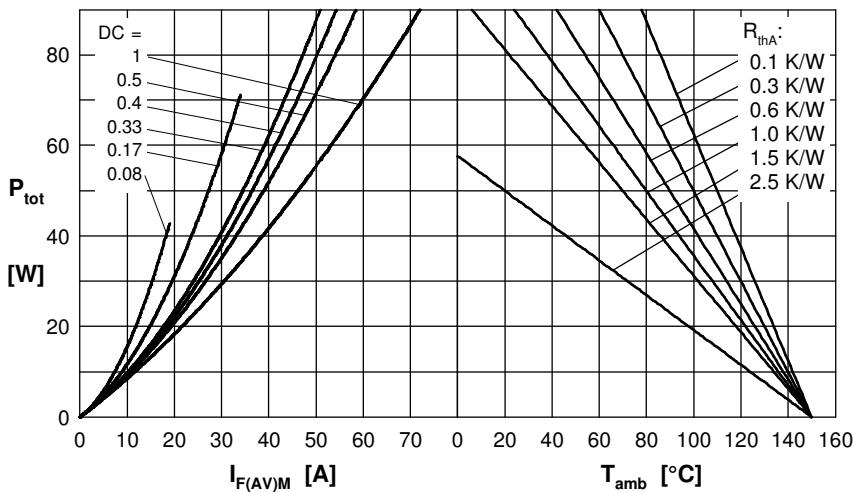
Fig. 3 I^2t vs. time per diode

Fig. 4 Power dissipation vs. forward current and ambient temperature per diode

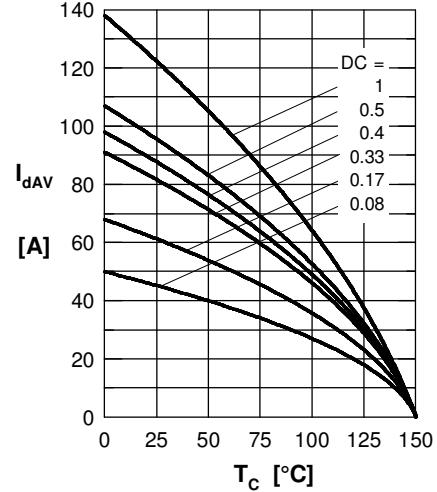


Fig. 5 Max. forward current vs. case temperature per diode

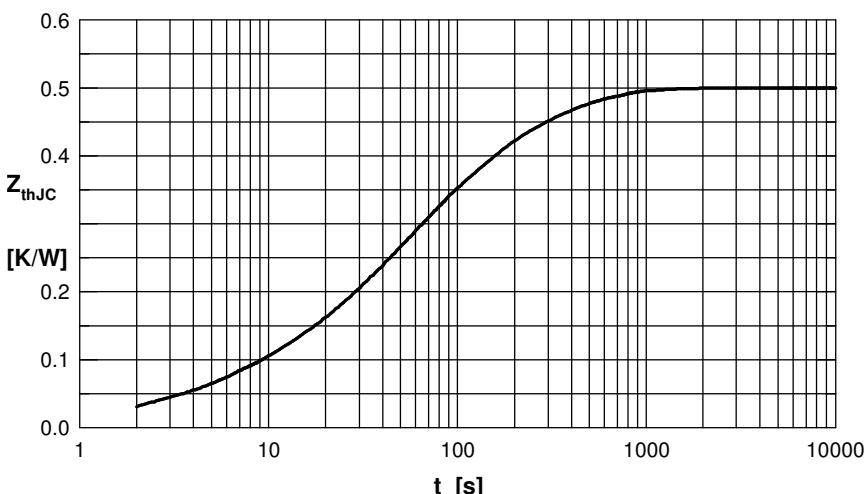


Fig. 6 Transient thermal impedance junction to case vs. time per diode

Constants for Z_{thJC} calculation:

i	R_{th} (K/W)	t_i (s)
1	0.040	0.004
2	0.003	0.010
3	0.140	0.030
4	0.120	0.300
5	0.197	0.080

Brake Diode

